

## ●General Description

This silicon carbide Power MOSFET device has been developed using ZMJ's advanced 2<sup>nd</sup> generation SiC MOSFET technology. The device features a very low  $R_{DS(on)}$  over the entire temperature range combined with low capacitances and very high switching operations. It improves application performance in frequency, energy efficiency, system size and weight reduction.

## ●Features

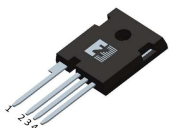
- High blocking voltage
- High speed switching with low capacitances
- Low  $R_{DS(on)}$  to minimize conductive loss
- Low gate charge for fast switching
- Low thermal resistance
- 100% avalanche tested
- AEC-Q101 qualified

## ●Application

- Motor drives
- On board charger
- DC-DC
- Auxiliary drives



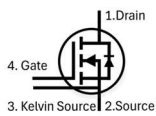
## ●Product Summary



TO-247-4

## ●Ordering Information

|                           |                |
|---------------------------|----------------|
| Part NO.                  | ZMCSA040R120C4 |
| Marking                   | ZMCS040R120    |
| Packing information       | TUBE BULK      |
| Basic ordering unit (pcs) | 450            |


 $V_{DS}=1200V$ 
 $R_{DS(ON)}=39mR$ 
 $I_D=47A$ 


## ●Absolute Maximum Ratings ( $T_A=25^{\circ}C$ , unless otherwise specified)

| Parameter                         | Symbol        | Conditions                                       | Min. | Max. | Unit |
|-----------------------------------|---------------|--------------------------------------------------|------|------|------|
| Drain-source voltage              | $V_{DS}$      |                                                  | -    | 1200 | V    |
| Gate-source voltage <sup>①</sup>  | $V_{GS}$      | Transient Voltage                                | -10  | 25   | V    |
|                                   | $V_{GS}$      | Static Voltage                                   | -10  | 24   | V    |
| Recommended turn on gate voltage  | $V_{GS(on)}$  |                                                  | 15   | 18   | V    |
| Recommended turn off gate voltage | $V_{GS(off)}$ |                                                  | -4   | 0    | V    |
| Continuous drain current          | $I_D$         | $V_{GS}=18V, T_C=25^{\circ}C$                    | -    | 47   | A    |
|                                   | $I_D$         | $V_{GS}=18V, T_C=75^{\circ}C$                    | -    | 39   | A    |
|                                   | $I_D$         | $V_{GS}=18V, T_C=100^{\circ}C$                   | -    | 33   | A    |
| Pulsed drain current <sup>①</sup> | $I_{DM}$      | Pulsed; $t_p \leq 10 \mu s; T_C = 25^{\circ}C$ ; | -    | 189  | A    |

|                                |           |                                                           |     |     |                    |
|--------------------------------|-----------|-----------------------------------------------------------|-----|-----|--------------------|
| Total power dissipation        | $P_D$     | $T_C=25^{\circ}\text{C}$                                  | -   | 221 | W                  |
| Total power dissipation        | $P_D$     | $T_A=25^{\circ}\text{C}$                                  | -   | 3.8 | W                  |
| Operating junction temperature | $T_J$     |                                                           | -55 | 175 | $^{\circ}\text{C}$ |
| Storage temperature            | $T_{STG}$ |                                                           | -55 | 175 | $^{\circ}\text{C}$ |
| Single pulse avalanche energy  | $E_{AS}$  | $L=0.5\text{mH}$ , $V_{GS}=18\text{V}$ , $R_g=25\Omega$ , | -   | 588 | mJ                 |

### ● Thermal resistance

| Parameter                              | Symbol           | Min. | Typ. | Max. | Unit                 |
|----------------------------------------|------------------|------|------|------|----------------------|
| Thermal resistance, junction - case    | $R_{thJC}$       | -    | -    | 0.68 | $^{\circ}\text{C/W}$ |
| Thermal resistance, junction - ambient | $R_{thJA}^{(2)}$ | -    | -    | 40   | $^{\circ}\text{C/W}$ |
| Soldering temperature                  | $T_{sold}$       | -    | -    | 260  | $^{\circ}\text{C}$   |

### ● Electronic Characteristics ( $T_J=25^{\circ}\text{C}$ , unless otherwise specified)

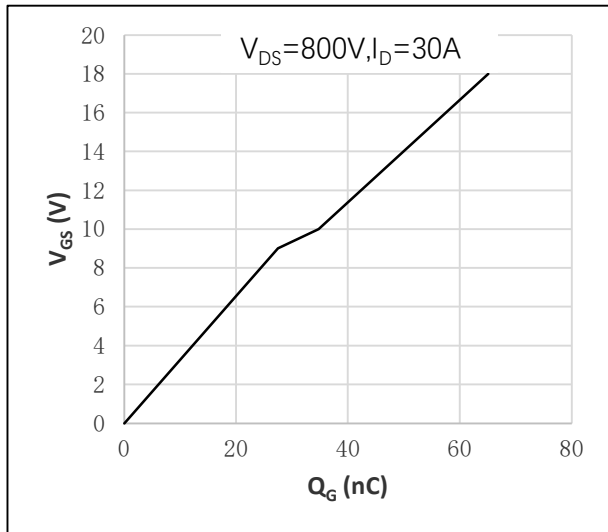
| Parameter                         | Symbol       | Condition                                                          | Min. | Typ. | Max. | Unit          |
|-----------------------------------|--------------|--------------------------------------------------------------------|------|------|------|---------------|
| Drain-source breakdown voltage    | $BV_{DSS}$   | $V_{GS}=0\text{V}$ , $I_D=250\mu\text{A}$                          | 1200 | -    | -    | V             |
| Gate threshold voltage            | $V_{GS(th)}$ | $V_{GS}=V_{DS}$ , $I_D=5\text{mA}$                                 | 2    | 2.8  | 4    | V             |
| Drain-source leakage current      | $I_{DSS}$    | $V_{GS}=0\text{V}$ , $V_{DS}=1200\text{V}$                         | -    | -    | 10   | $\mu\text{A}$ |
| Gate- source leakage current      | $I_{GSS}$    | $V_{GS}=-10\text{V}$ , $V_{DS}=0\text{V}$                          | -    | -    | -100 | nA            |
|                                   |              | $V_{GS}=25\text{V}$ , $V_{DS}=0\text{V}$                           | -    | -    | 100  | nA            |
| Static drain-source on resistance | $R_{DS(ON)}$ | $V_{GS}=18\text{V}$ , $I_D=30\text{A}$ , $T_J=25^{\circ}\text{C}$  | -    | 39   | 47   | m $\Omega$    |
|                                   |              | $V_{GS}=18\text{V}$ , $I_D=30\text{A}$ , $T_J=175^{\circ}\text{C}$ | -    | 78   | -    | m $\Omega$    |
|                                   |              | $V_{GS}=15\text{V}$ , $I_D=30\text{A}$ , $T_J=25^{\circ}\text{C}$  | -    | 47   | -    | m $\Omega$    |
| Forward transconductance          | $g_{FS}$     | $V_{DS}=10\text{V}$ , $I_{SD}=30\text{A}$                          | -    | 7.5  | -    | S             |
| Diode forward voltage             | $V_{FSD}$    | $V_{GS}=-4\text{V}$ , $I_{SD}=30\text{A}$                          | -    | 4.4  | 5    | V             |

### ● Dynamic characteristics ( $T_J=25^{\circ}\text{C}$ , unless otherwise specified)

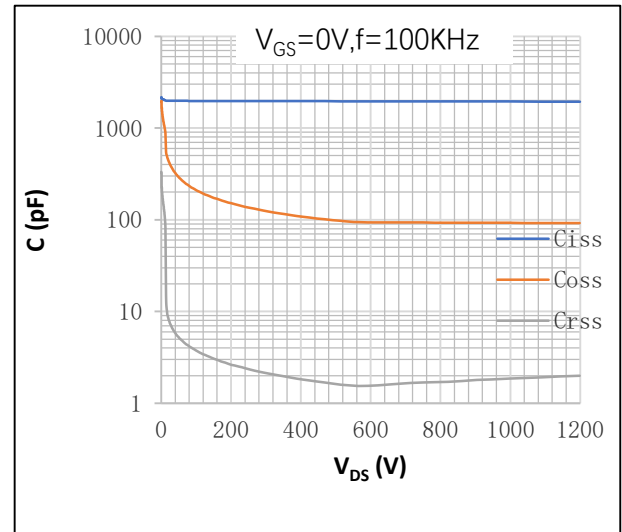
| Parameter                    | Symbol    | Condition                                                                  | Min. | Typ.  | Max. | Unit          |
|------------------------------|-----------|----------------------------------------------------------------------------|------|-------|------|---------------|
| Input capacitance            | $C_{iss}$ | $f=100\text{KHz}$ , $V_{DS}=800\text{V}$ , $V_{GS}=0\text{V}$              | -    | 2061  | -    | pF            |
| Output capacitance           | $C_{oss}$ |                                                                            | -    | 94    | -    | pF            |
| Reverse transfer capacitance | $C_{rss}$ |                                                                            | -    | 1.6   | -    | pF            |
| Output charge                | $Q_{oss}$ | $f=100\text{KHz}$ , $V_{GS}=0\text{V}$ , $V_{DS}=0\text{V to }800\text{V}$ | -    | 123.3 | -    | nC            |
| Coss stored energy           | $E_{oss}$ |                                                                            | -    | 34.5  | -    | $\mu\text{J}$ |
| Gate resistance              | $R_g$     | $f=1\text{MHz}$                                                            | -    | 1.4   | -    | $\Omega$      |

|                         |              |                                                                                      |   |      |   |    |
|-------------------------|--------------|--------------------------------------------------------------------------------------|---|------|---|----|
| Total gate charge       | $Q_g$        | $V_{DD} = 800V,$<br>$I_D = 30A,$<br>$V_{GS} = -4V/18V$                               | - | 65.1 | - | nC |
| Gate-source charge      | $Q_{gs}$     |                                                                                      | - | 27.5 | - | nC |
| Gate-drain charge       | $Q_{gd}$     |                                                                                      | - | 7.3  | - | nC |
| Turn-on delay time      | $t_{D(on)}$  | $V_{GS}=-4V/18V,$<br>$V_{DS}=800V,$<br>$R_G=30\Omega,$<br>$I_D=20A,$<br>$L=200\mu H$ | - | 32   | - | ns |
| Turn-on rise time       | $t_r$        |                                                                                      | - | 20   | - | ns |
| Turn-off delay time     | $t_{D(off)}$ |                                                                                      | - | 79   | - | ns |
| Turn-off fall time      | $t_f$        |                                                                                      | - | 13   | - | ns |
| Turn-on energy          | $E_{on}$     |                                                                                      | - | 356  | - | uJ |
| Turn-off energy         | $E_{off}$    |                                                                                      | - | 286  | - | uJ |
| Reverse recovery time   | $t_{rr}$     | $V_{DD}=800V, dI_S/dt =$<br>$890A/\mu s, I_S=20A$                                    | - | 36   | - | ns |
| Reverse recovery charge | $Q_{rr}$     |                                                                                      | - | 223  | - | nC |

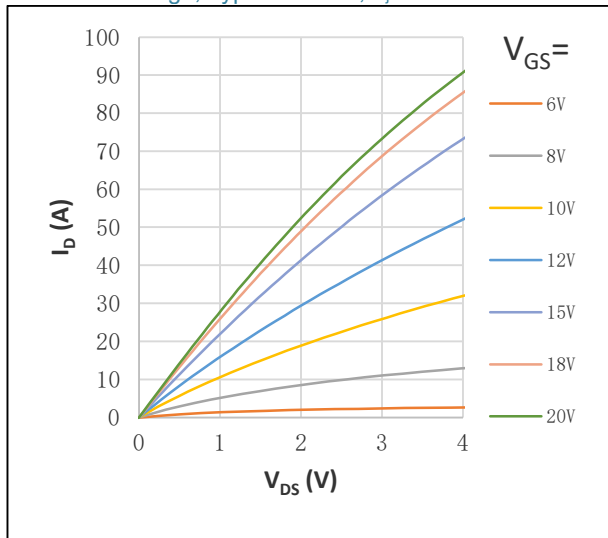
● Fig.1 Gate-source voltage as a function of gate charge; Typical values;  $T_j=25^\circ\text{C}$



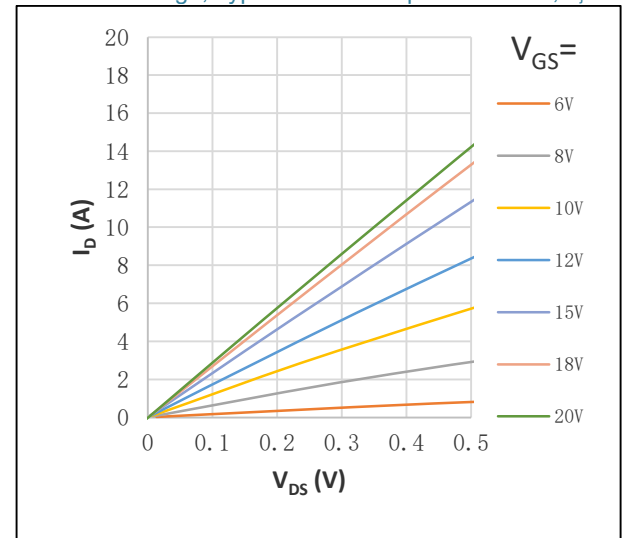
● Fig.2 Input, output and reverse transfer capacitances as a function of drain-source voltage; Typical values;  $T_j=25^\circ\text{C}$



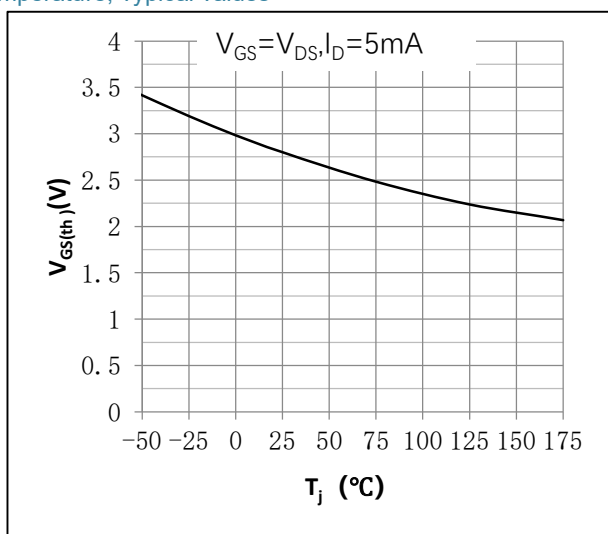
● Fig.3 Output characteristics: drain current as a function of drain-source voltage; Typical values;  $T_j=25^\circ\text{C}$



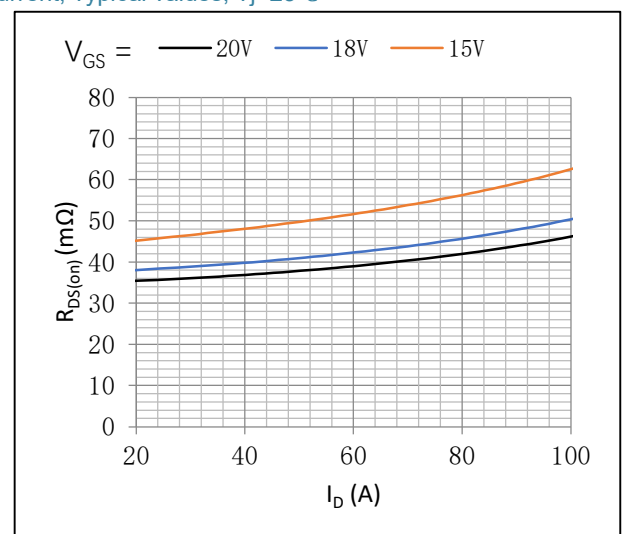
● Fig.4 Output characteristics: drain current as a function of drain-source voltage; Typical values: Expanded curve;  $T_j=25^\circ\text{C}$



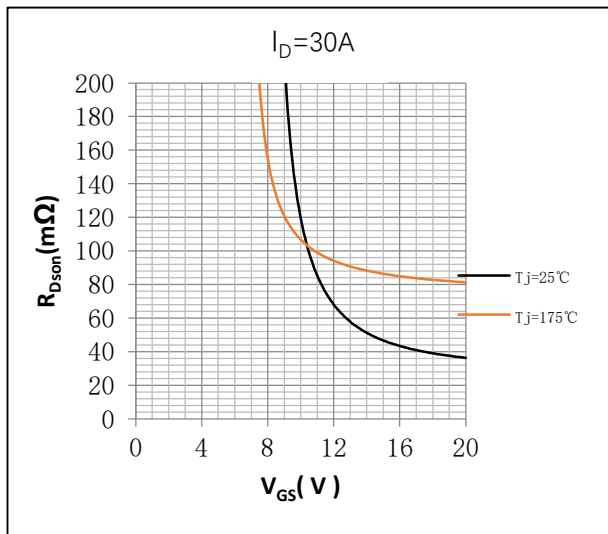
● Fig.5 Gate-source threshold voltage as a function of junction temperature; Typical values



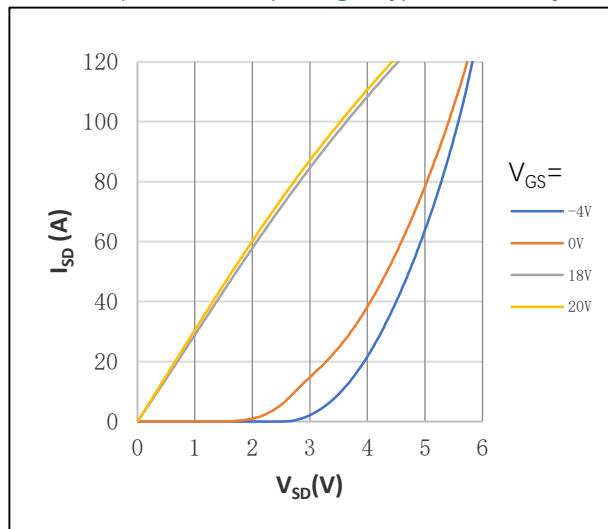
● Fig.6 Drain-source on-state resistance as a function of drain current; Typical values;  $T_j=25^\circ\text{C}$



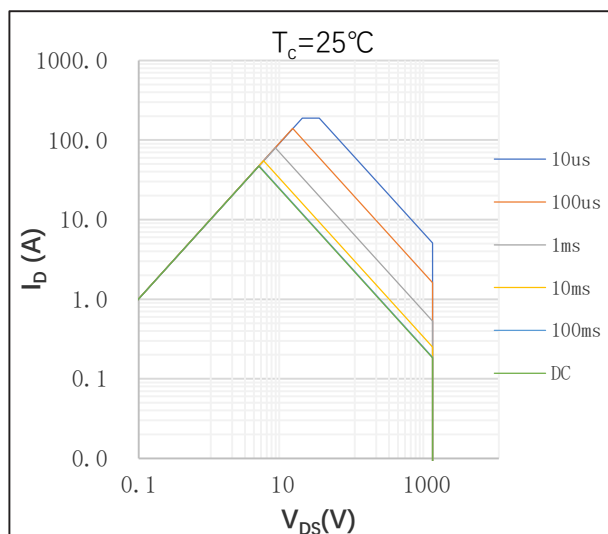
● Fig.7 Drain-source on-state resistance as a function of gate-source voltage; Typical values



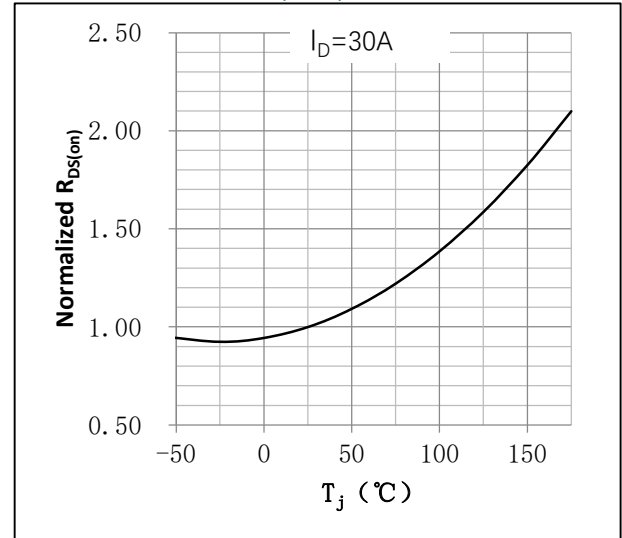
● Figure 9. Source (diode forward) current as a function of source-drain (diode forward) voltage; Typical values; T<sub>J</sub>=25°C



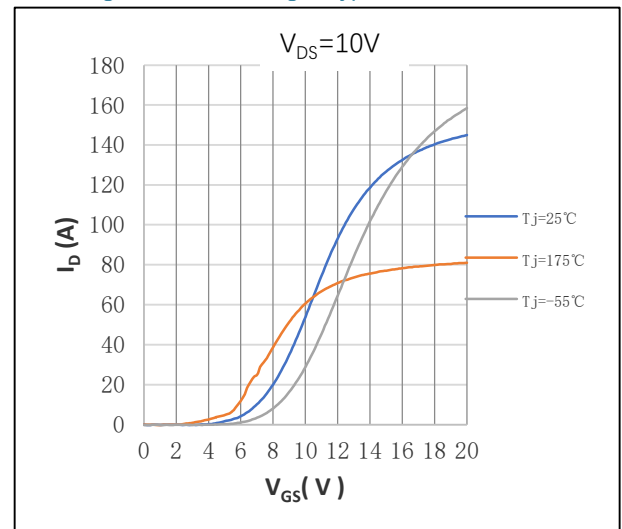
● Fig.11 Safe operating area: continuous and peak drain currents as a function of drain-source voltage; Calculative values



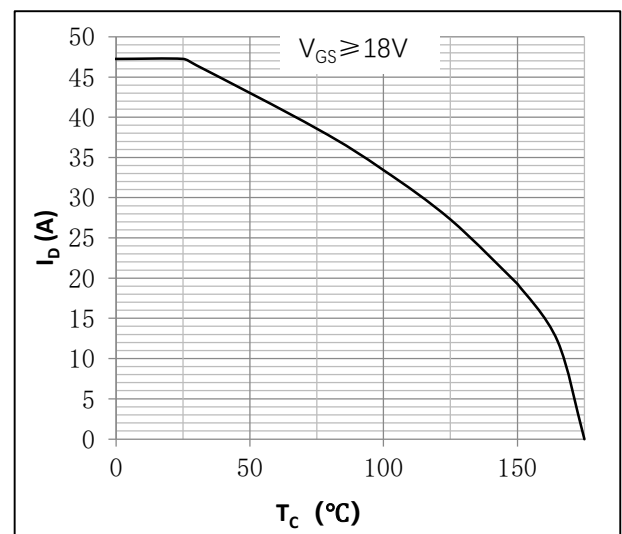
● Fig.8 Normalized drain-source on-state resistance factor as a function of junction temperature; Typical values Normalized On-Resistance= $R_{DS(on)}/R_{DS(on)}(25^{\circ}\text{C})$



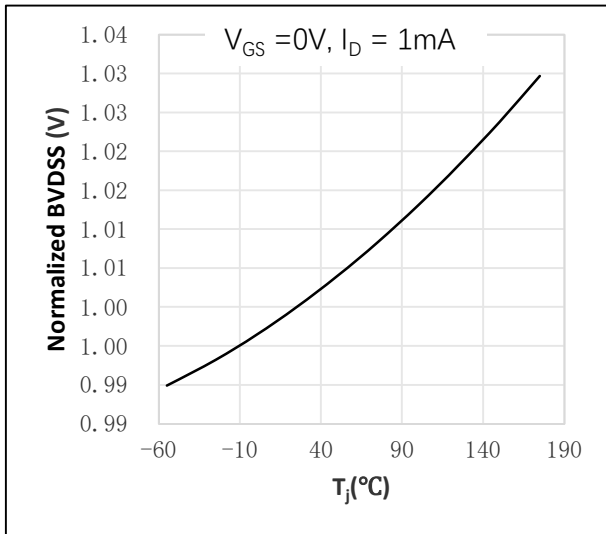
● Figure 10. Transfer characteristics: drain current as a function of gate-source voltage; Typical values



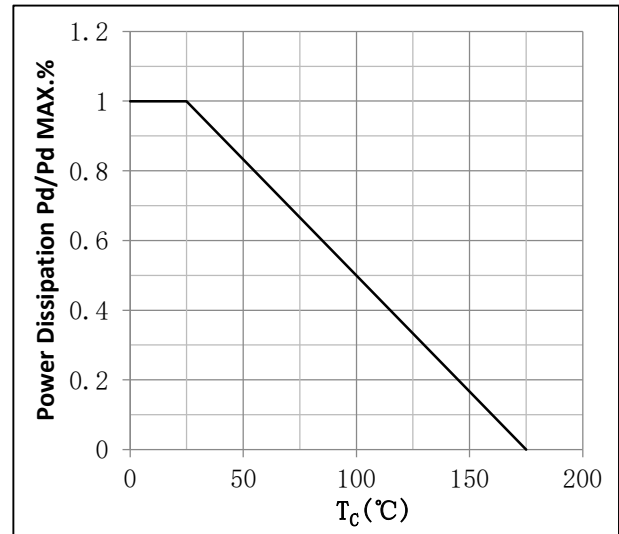
● Fig.12 Continuous drain current as a function of case temperature<sup>3</sup>; Calculative values



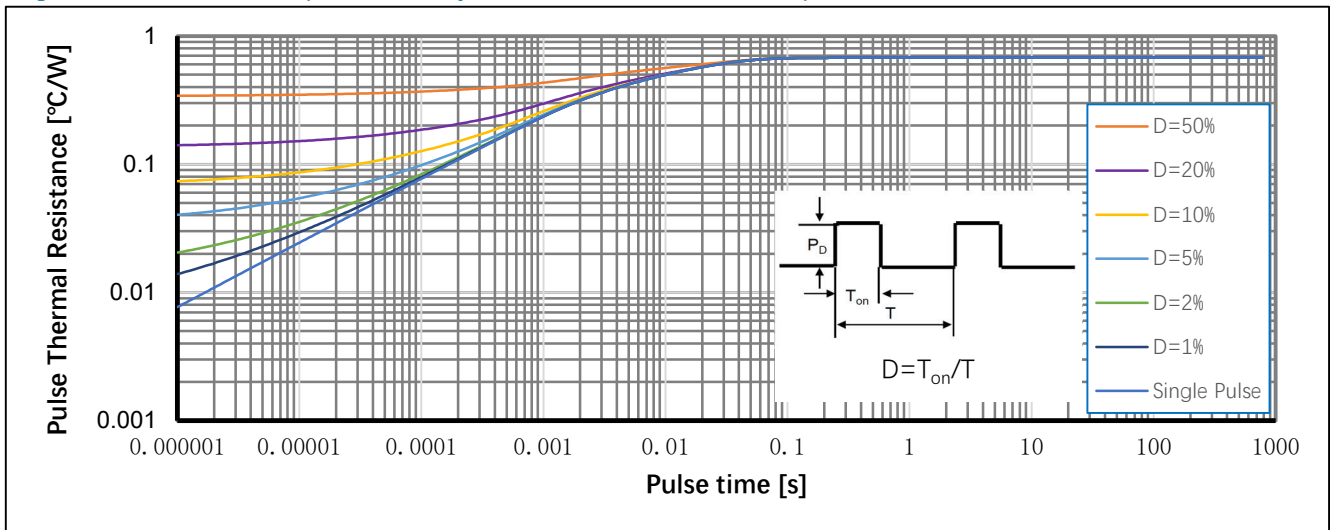
● Fig.13 Drain-source breakdown voltage as a function of junction temperature; Typical values Normalized  $BV_{DSS} = BV_{DSS}/BV_{DSS}(25^{\circ}\text{C})$



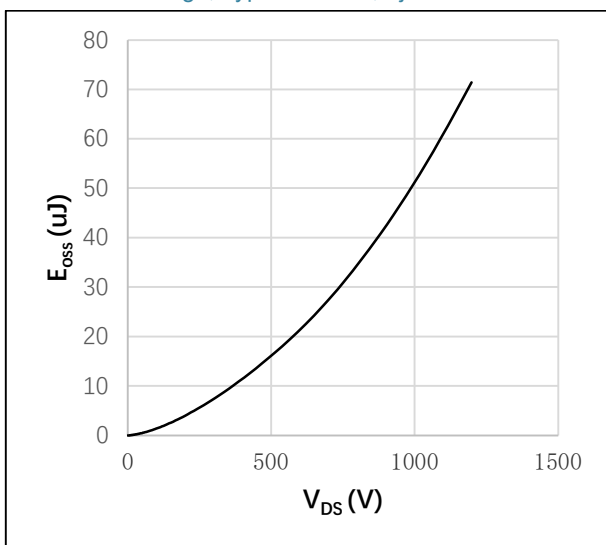
● Fig.14 Normalized total power dissipation as a function of case temperature; Calculative values Normalized Power Dissipation  $= P_d/P_d(25^{\circ}\text{C})$



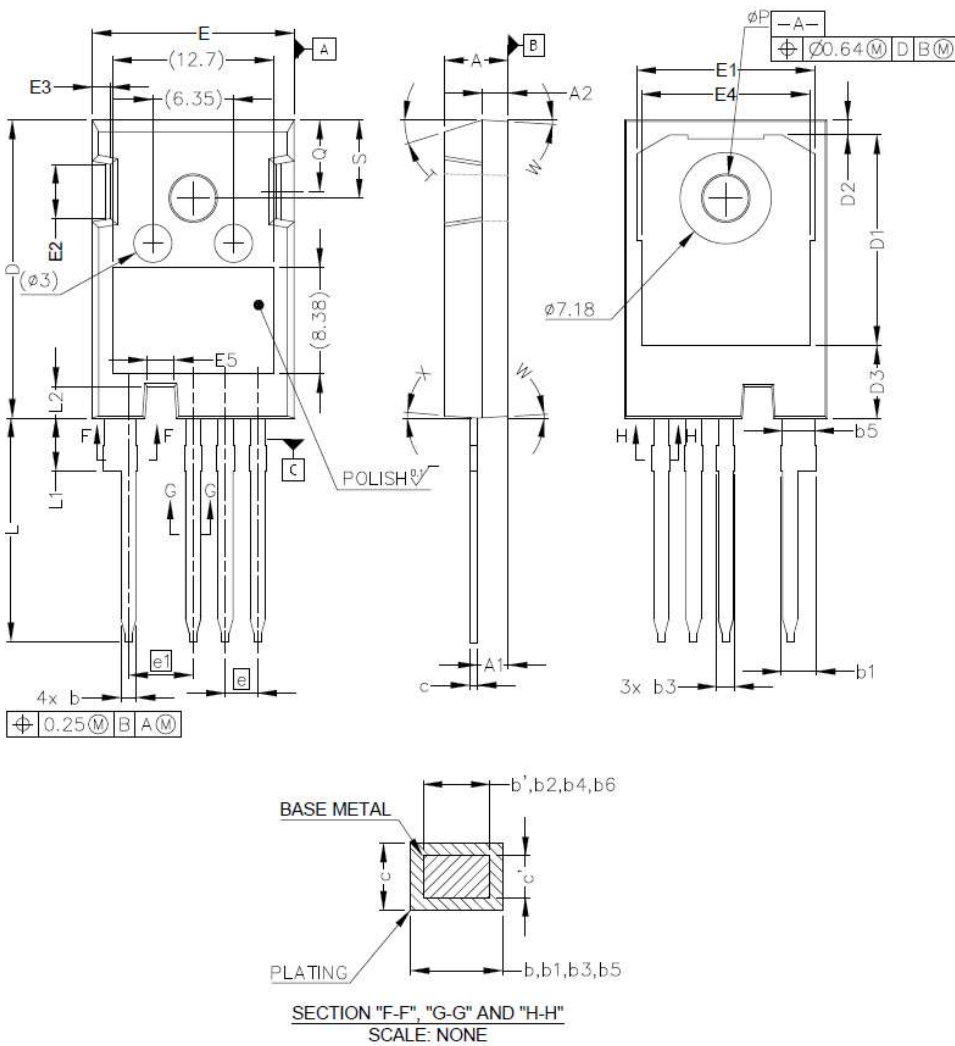
● Fig.15 Transient thermal impedance from junction to case as a function of pulse duration; max values



● Fig.16 Output capacitor stored energy as a function of drain-source voltage; Typical values;  $T_j = 25^{\circ}\text{C}$



# ● Package Outline



## ● Note

① Practically the current will be limited by PCB, thermal design and operating temperature.  $V_{GS}=18V$ .

## ● Disclaimer

- Reproducing and modifying information of the document is prohibited without permission from ZMJ SEMICONDDUCTORS CO., LTD.
- ZMJ SEMICONDDUCTORS CO., LTD. reserves the rights to make changes of the content herein the document anytime without notification. Please refer to our website for the latest document.
- ZMJ SEMICONDDUCTORS CO., LTD. disclaims any and all liability arising out of the application or use of any product including damages incidentally and consequentially occurred.
- ZMJ SEMICONDDUCTORS CO., LTD. does not assume any and all implied warranties, including warranties of fitness for particular purpose, non-infringement and merchantability.
- Applications shown on the herein document are examples of standard use and operation. Customers are responsible in comprehending the suitable use in particular applications. ZMJ SEMICONDDUCTORS CO., LTD. makes no representation or warranty that such applications will be suitable for the specified use without further testing or modification.
- The products shown herein are not designed and authorized for equipments relating to human life and for any applications concerning life-saving or life-sustaining, such as medical instruments, aerospace machinery et cetera. Customers using or selling these products for use in such applications do so at their own risk and agree to fully indemnify ZMJ SEMICONDDUCTORS CO., LTD. for any damages resulting from such improper use or sale.
- Since ZMJ uses lot number as the tracking base, please provide the lot number for tracking when complaining.

●Revision History

| Version | Date     | Change |
|---------|----------|--------|
| A       | 2025/8/6 | New    |
|         |          |        |
|         |          |        |
|         |          |        |
|         |          |        |